


☐ Drafts

☐ Pending

☒ Active

☒ L1: (29799) (inspect\$4 or control\$5)near9 instrument

☒ L2: (36028) (inspect\$4 or control\$5)near9 (wafer or mask)

☒ L3: (3733) mask and parameter and setup

☒ L4: (1113) recip\$4 near9 parameter

☒ L5: (3) 11 and 12 and 13 and 14

☐ Failed

☐ Saved

☐ Favorites

☐ Tagged (0)

☐ UDC

☐ Queue

☐ Trash

 Search
 DBs: USPAT; US-PGPUB

☒ Plurals

 Default operator: OR

☒ Highlight all hit terms initially

 11 and 12 and 13 and 14

☒ BRS form

☒ IS&R ...

☒ Image

☒ Text

☒ HTML

	U	I	Document ID	Issue Date	Pages	Title	Current OR
1	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 20020176074 A1	20021128	18	Measurement system cluster	356/237.5
2	<input type="checkbox"/>	<input type="checkbox"/>	US 20020165636 A1	20021107	24	Systems and methods for metrology recipe and model generation	700/121
3	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 4570217 A	19860211	294	Man machine interface	790/83

☒ Hits ☒ Details ☒ HTML

Ready

NUM